

FSTU3253

Dual 4:1 Multiplexer/Demultiplexer Bus Switch with –2V Undershoot Protection

General Description

The Fairchild Switch FSTU3253 is a dual 4:1 high-speed CMOS TTL-compatible multiplexer/demultiplexer bus switch. The low On Resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.

When $\overline{OE}$ is LOW, S_0 and S_1 connect the A Port to the selected B Port output. When $\overline{OE}$ is HIGH, the switch is OPEN and a high-impedance state exists between the two ports.

The A and B Ports are protected against undershoot to support an extended range to 2.0V below ground. Fairchild's integrated Undershoot Hardened Circuit (UHC™) senses undershoot at the I/O and responds by preventing voltage differentials from developing and turning the switch on.

Features

- Undershoot hardened to –2.0V
- 4Ω switch connection between two ports
- Minimal propagation delay through the switch
- Low I_{CC}
- Zero bounce in flow-through mode
- Control inputs compatible with TTL level
- See application note AN-5008 and AN-5021 for details on undershoot

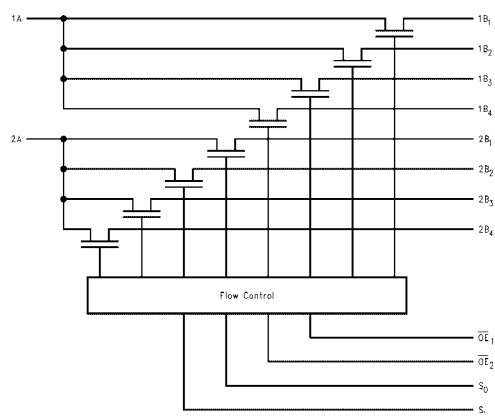
Ordering Code:

Order Number	Package Number	Package Description
FSTU3253M	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
FSTU3253QSC	MQA16	16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150" Wide
FSTU3253MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

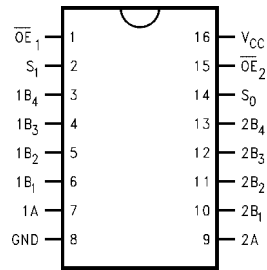
Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

FSTU3253 Dual 4:1 Multiplexer/Demultiplexer Bus Switch with –2V Undershoot Protection

Logic Diagram



Connection Diagram



Pin Descriptions

Pin Name	Description
$\overline{OE}_1, \overline{OE}_2$	Bus Switch Enables
S_0, S_1	Select Inputs
A	Bus A
B ₁ , B ₂ , B ₃ , B ₄	Bus B

Truth Table

S ₁	S ₀	$\overline{OE}_1$	$\overline{OE}_2$	Function
X	X	H	X	Disconnect 1A
X	X	X	H	Disconnect 2A
L	L	L	L	A = B ₁
L	H	L	L	A = B ₂
H	L	L	L	A = B ₃
H	H	L	L	A = B ₄

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	–0.5V to +7.0V
DC Switch Voltage (V_S)	–2.0V to +7.0V
DC Input Voltage (V_{IN}) (Note 2)	–0.5V to +7.0V
DC Input Diode Current (I_{IK}) $V_{IN} < 0V$	–50 mA
DC Output (I_{OUT}) Sink Current	128 mA
DC V_{CC} /GND Current (I_{CC}/I_{GND})	+/- 100 mA
Storage Temperature Range (T_{STG})	–65°C to +150 °C

Recommended Operating Conditions (Note 3)

Power Supply Operating (V_{CC})	4.0V to 5.5V
Input Voltage (V_{IN})	0V to 5.5V
Output Voltage (V_{OUT})	0V to 5.5V
Input Rise and Fall Time (t_r, t_f)	
Switch Control Input	0 ns/V to 5 ns/V
Switch I/O	0 ns/V to DC
Free Air Operating Temperature (T_A)	–40 °C to –85 °C

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The Recommended Operating Conditions tables will define the conditions for actual device operation.

Note 2: The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

Note 3: Unused control inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = -40\text{ °C to }+85\text{ °C}$			Units	Conditions
			Min	Typ (Note 4)	Max		
V_{IK}	Clamp Diode Voltage	4.5			–1.2	V	$I_{IN} = -18\text{ mA}$
V_{IH}	High Level Input Voltage	4.0–5.5	2.0			V	
V_{IL}	Low Level Input Voltage	4.0–5.5			0.8	V	
I_I	Input Leakage Current	5.5			±1.0	μA	$0 \leq V_{IN} \leq 5.5V$
		0			10	μA	$V_{IN} = 5.5V$
I_{OZ}	OFF-STATE Leakage Current	5.5			±1.0	μA	$0 \leq A, B \leq V_{CC}$
R_{ON}	Switch On Resistance (Note 5)	4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 64\text{ mA}$
		4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 30\text{ mA}$
		4.5		8	15	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{ mA}$
		4.0		11	20	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{ mA}$
I_{CC}	Quiescent Supply Current	5.5			3	μA	$V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0$
ΔI_{CC}	Increase in I_{CC} per Input	5.5			2.5	mA	One Input at 3.4V Other Inputs at V_{CC} or GND
V_{IKU}	Voltage Undershoot	5.5			–2.0	V	$0.0\text{ mA} \geq I_{IN} \geq -50\text{ mA}$ $\overline{OE} = 5.5V$

Note 4: Typical values are at $V_{CC} = 5.0V$ and $T_A = +25^\circ\text{C}$

Note 5: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

AC Electrical Characteristics

Symbol	Parameter	T _A = -40 °C to +85 °C C _L = 50pF, R _U = R _D = 500Ω				Units	Conditions	Figure Number
		V _{CC} = 4.5 – 5.5V		V _{CC} = 4.0V				
		Min	Max	Min	Max			
t _{PHL} , t _{PLH}	Propagation Delay Bus to Bus (Note 6)		0.25		0.25	ns	V _I = OPEN	Figures 2, 3
	Propagation Delay, Select to Bus A	0.5	5.7		6.2			
t _{PZH} , t _{PZL}	Output Enable Time, Select to Bus B	0.5	5.7		6.3	ns	V _I = 7V for t _{PZL} V _I = OPEN for t _{PZH}	Figures 2, 3
	Output Enable Time, I _{OE} to Bus A, B	0.5	4.9		5.4			
t _{PHZ} , t _{PLZ}	Output Disable Time, Select to Bus B	0.5	6.2		6.3	ns	V _I = 7V for t _{PLZ} V _I = OPEN for t _{PHZ}	Figures 2, 3
	Output Disable Time, I _{OE} to Bus A, B	0.5	6.0		6.1			

Note 6: This parameter is guaranteed by design but is not tested. The bus switch contributes no propagation delay other than the RC delay of the typical On resistance of the switch and the 50pF load capacitance, when driven by an ideal voltage the source (zero output impedance).

Capacitance (Note 7)

Symbol	Parameter	Typ	Max	Units	Conditions
C _{IN}	Control Pin Input Capacitance	3		pF	V _{CC} = 5.0V
C _{I/O}	A Port	13		pF	V _{CC} , $\overline{\text{OE}}$ = 5.0V
	B Port	5		pF	

Note 7: T_A = +25°C, f = 1 MHz, Capacitance is characterized but not tested.

Undershoot Characteristic (Note 8)

Symbol	Parameter	Min	Typ	Max	Units	Conditions
V _{OUTU}	Output Voltage During Undershoot	2.5	V _{OH} - 0.3		V	Figure 1

Note 8: This test is intended to characterize the device's protective capabilities by maintaining output signal integrity during an input transient voltage undershoot event.

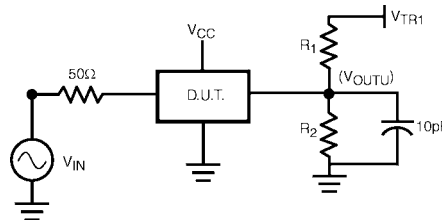
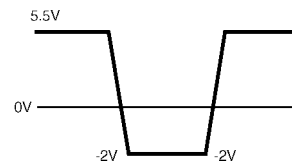


FIGURE 1.

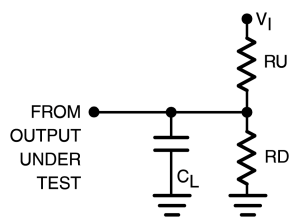
Device Test Conditions

Parameter	Value	Units
V _{IN}	see Waveform	V
R ₁ = R ₂	100K	Ω
V _{TRI}	11.0	V
V _{CC}	5.5	V

Transient Input Voltage (V_{IN}) Waveform



AC Loading and Waveforms



Note: Input driven by 50 Ω source terminated in 50 Ω

Note: C_L includes load and stray capacitance

Note: Input PRR = 1.0 MHz, $t_W = 500$ ns

FIGURE 2. AC Test Circuit

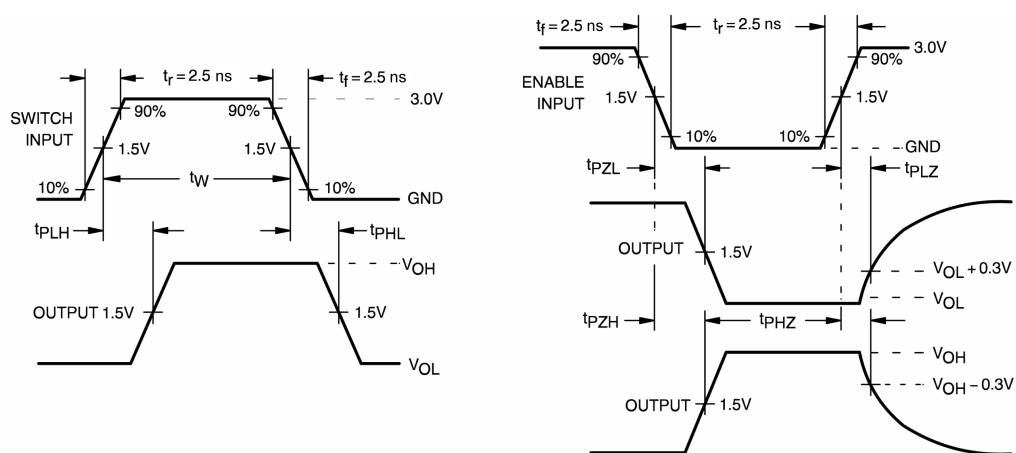
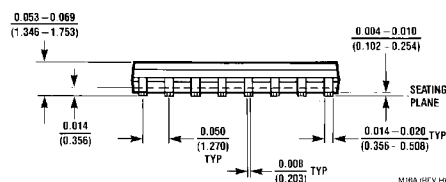
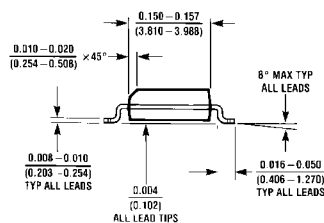
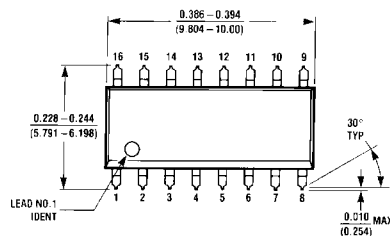
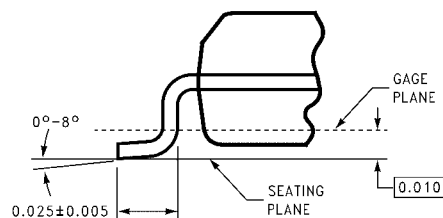
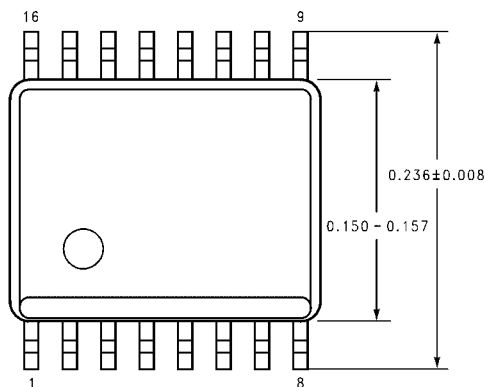


FIGURE 3. AC Waveforms

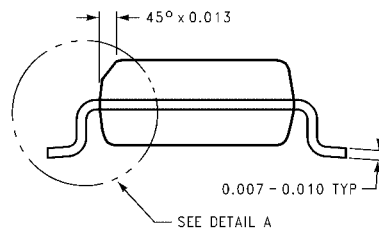
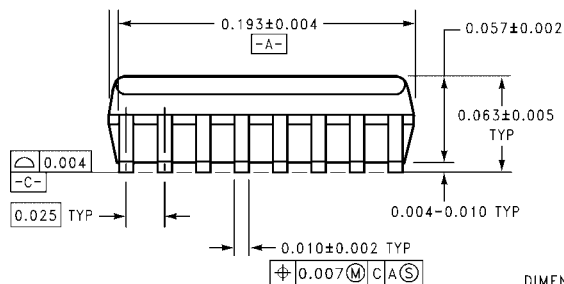
Physical Dimensions inches (millimeters) unless otherwise noted



**16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
Package Number M16A**



**DETAIL A
TYPICAL, SCALE: 40%**

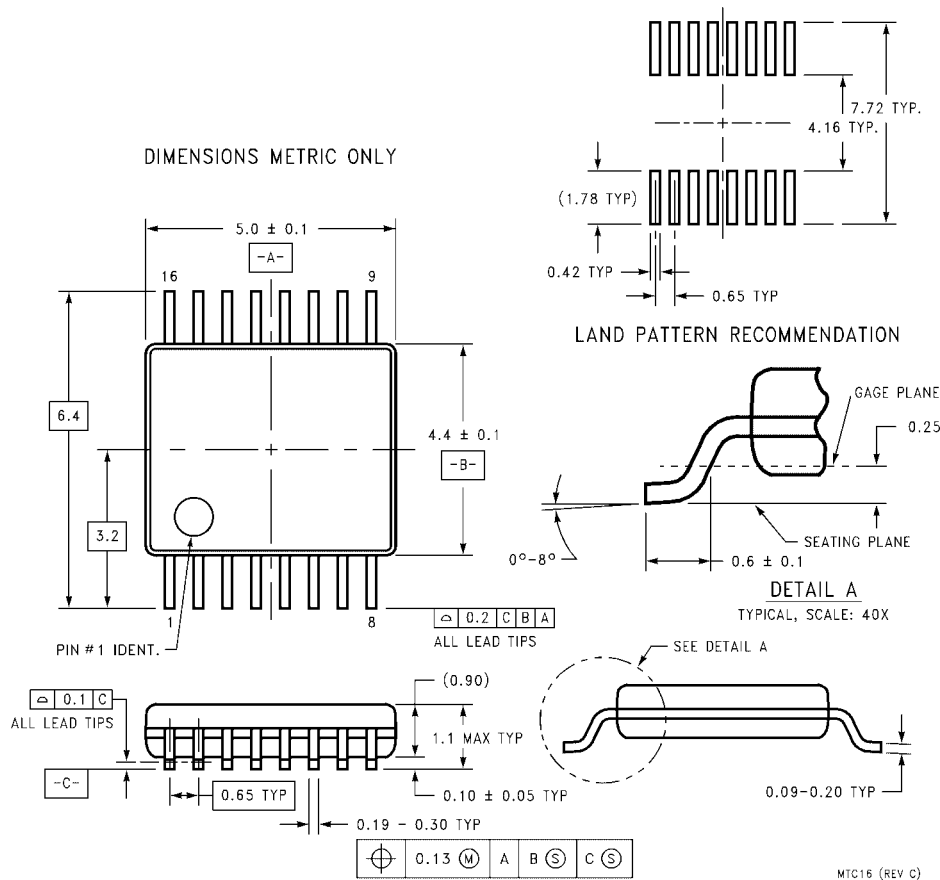


DIMENSIONS ARE IN INCHES

MQA16 (REV A)

**16-Lead Quarter Size Outline Package (QSOP), JEDEC MO-137, 0.150" Wide
Package Number MQA16**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



Technology Description

The Fairchild Switch family derives from and embodies Fairchild's proven switch technology used for several years in its 74LVX3L384 (FST3384) bus switch product.

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